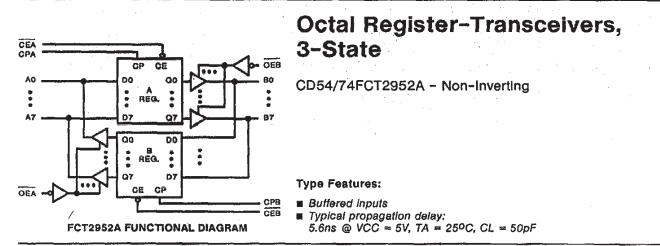
FCT Interface Logic



The CD54FCT2952A was not acquired from Harris Semiconductor.

CD54/74FCT2952A



The CD54/74FCT2952A octal register-transceiver uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that ilmits the output-HIGH level to two diode drops below VCC. This resultant lowering of output swing (OV to 3.7V) reduces power bus ringing (a source of EMI) and minimizes VCC bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 to 64 milliamperes.

These devices contain two 8-bit back-to-back registers that store data flowing in both directions between two bidirectional buses. Each register has separate clock, clock enable, and 3-state output enable signals associated with it.

The CD54/74FCT2952A is supplied in the 24-lead smalloutline plastic packages (M suffix). This package type is operable over two temperature ranges: Commercial (0°C to +70°C) and Extended Industrial (-55°C to +125°C).

REGISTER FUNCTION TABLE (APPLIES TO A OR B REGISTER)

l		INPUTS		INTERNAL			
	D	СР	ĈĒ	Q	FUNCTION		
	х	x	н	NC	Hold Data		
	L H		L L	L H	Load Data		

Family Features:

- SCR-latchup-resistant BICMOS process and circuit design
- FCTXXXXA Speed of bipolar FAST*/AS/S
- 64/48-mA output sink current (commercial/extended industrial)
- Output voltage swing limited to 3.7V @ VCC = 5V
- Controlled output-edge rates
- Input/output Isolation to VCC
- BICMOS technology with low gulescent power

* FAST is a registered trademark of Fairchild Semiconductor Corp.

The CD54FCT2952A is also available in chip form (H suffix). This unpackaged device is operable over the -55° C to $+125^{\circ}$ C temperature range.

OUTPUT CONTROL

	INTERNAL	OUTPUTS	-	
ŌĒ	Q	FCT2952A	FUNCTION	
н	x	z	Disable Outputs]
L L	L H	L H	Enable Outputs	

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MAXIMUM RATINGS, Absolute-Maximum Values:

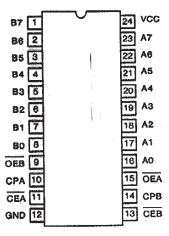
	-0.5V to 6V
DC SUPPLY-VOLTAGE (VCC) DC INPUT DIODE CURRENT, IIK (for VI < -0.5V)	–20mA
DC OUTPUT DIODE CURRENT, IOK (for VO < -0.5V)	-50mA
DC OUTPUT SINK CURRENT per Output Pin, IO	470mA
DC OUTPUT SINK CORRENT per Output Pin, IO	-30mA
DC OUTPUT SOURCE CURHENT per Output Pin, IO	4/0m/
DC VCC CURRENT (ICC)	
DC OUTPUT SOURCE CORHENT per Output Pin, IO DC VCC CURRENT (ICC). DC GROUND CURRENT (IGND)	
POWER DISSIPATION PER PACKAGE (PD): For TA = -55°C to +70°C (PACKAGE TYPE M)	
For TA = -55°C to +70°C (PACKAGE TYPE M)	
For TA = $+70^{\circ}$ C to $+125^{\circ}$ C (PACKAGE TYPE M)	Derate Linearly at 6mW/°C to 70mW
	-55°C to +125°C
PACKAGE TYPE M STORAGE TEMPERATURE (Tstg)	-65°C to +150°C
STORAGE TEMPERATURE (1stg)	
LEAD TEMPERATURE (DURING SOLDERING):	100500
At distance 1/16 in. \pm 1/32 in. (1.59mm \pm 0.79mm) from case for 10s maximum	+200°G
Unit Inserted into PC board min. thickness 1/16 in. (1.59mm) with solder contacting lead t	ips only

RECOMMENDED OPERATING CONDITIONS:

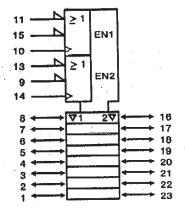
The following are normal operating ranges for these devices. For maximum reliability, devices should always be operated within these ranges.

		LIM		
c	HARACTERISTIC	MIN	MAX	UNITS
Supply-Voltage Range, VCC*:	CD74 Series, TA = 0° C to 70° C	4.75	5.25	V
a de la sector de la Esta de la sector de	CD54 Series, TA = -55°C to +125°C	4,5	5.5	V
DC Input Voltage, VI	· · · · · · · · · · · · · · · · · · ·	0	VCC	v
DC Output Voltage, VO		0	<u>≤</u> VCC	V
Operating Temperature, TA		-55	+125	°C
Input Rise and Fall Slew Rate, dt/dv		0	10	ns/V

* Unless otherwise specified, all voltages are referenced to ground.



CD54/74FCT2952A TYPE



TERMINAL ASSIGNMENT

IEC LOGIC SYMBOL

STATIC ELECTRICAL CHARACTERISTICS

FCT Series: 74FCT Commercial Temperature Range, 0°C to +70°C; VCC max = 5.25V, VCC min = 4.75V 54FCT Extended Industrial Temperature Range, -55°C to +125°C; VCC max = 5.6V, VCC min = 4.5V

						AMBIE	ENT TEMP	ERATUR	E (TA)		
		TEST CONDITIONS			+25°C		0°C to	+70ºC	-55°C to +125°C		
CHARACTERISTICS		VI (V)	IO (mA)	VCC (V)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
High-Level Input Voltage	VIH	-		4.5 to 5,5	2	**	2		2		v
Low-Level Input Voltage	VIL			4,5 to 5.5	-	0.8		0.8		0.8	v
High-Level Output Voltage		VIH or	-15	MIN	2,4	-	2.4	<u>-</u>	-	-	V
	VOH	VIL	-12	MIN	2.4	-	- 1		2.4	-	V
Low-Level Output Voltage		VIH or	64	MIN	-	0.55	-	0.55	-	-	v
	VOL	VIL	48	MIN	· •	0.55	-	-	-	0.55	v
High-Level Input Current	11H	vcc		мах		0.1	-	1	-	1	Ац
Low-Level Input Current	IIL.	GND		MAX	-	-0.1	-	-1	-	-1	μΑ
3-State Leakage Current	IOZH	vcc		MAX	-	0.5	-	10	-	10	Aμ
	IOZL	GND		MAX	-	-0.5	-	-10	-	-10	μΑ
Short-Circuit Output Current *	IOS	VCC or GND VO = 0		мах	-60	-	-60	-	-60		mA
Input Clamp Voltage	VIK	VCC or GND	-18	MIN		-1.2	-	-1.2	-	-1.2	v
Quiescent Supply Current, MSI	ICC	VCC or GND	0	мах		8	_	80	-	500	μΑ
Additional Quiescent Supply Current per Input Pin TTL Inputs High, 1 Unit Load	AICC	3.4V†		мах	- 1997 - 1997 - 1997 - 1997	1.6	-	1.6	-	2	mA

† Inputs that are not measured are at VCC or GND.

FCT Input Loading: All inputs are 1 unit load. Unit load is AICC limit specified in Static Characteristics Chart, e.g., 1.6mA max. @ +70°C.



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CD54/74FCT2952A

		VCC (V)	+25°C	0°C to +70°C		-55°C to +125°C		
PARAMETER	SYMBOL		түр	MIN	MAX	MIN	MAX	UNITS
Clock Pulse Width CPA, CPB	tW	5†	-	3	-	3	-	ns
Setup Time An, Bn to CPA, CPB	tSU	5		2	-	2.5	-	ns
CEA, CEB to CPA, CPB	tSU	5	-	3	•	3		ns
Hold Time An, Bn to CPA, CPB	tH	5	-	2	•	2		ns
CEA, CEB to CPA, CPB	tH	5:	•	2	•	2	-	

† 5V: min. Is at 4.5V., min. is at 4.75V for 0°C to +70°C, typ. Is at 5V.

Switching Specifications FCT Series: tr, tf = 2.5ns, CL = 50pF, RL - See Figure 4

		VCC (V)	+25°C	0°C to	0°C to +70°C		> +125°C	
PARAMETER	SYMBOL		ТҮР	MIN	MAX	MIN	MAX	UNITS
Propagation Delays CPA, CPB to Bn, An	tPLH, tPHL	5†	5.5	2	10	2	11	ns
Output EnableTime OEA or OEB to An or Bn	tPZL, tPZH	5	5.5	1.5	10.5	1.5	13	ns
Output Disable Time OEA or OEB to An or Bn	tPLZ, tPHZ	5	5.5	1.5	10	1.5	10	ns
Power Dissipation Capacitance	CPD§	•	56 Typical					рF
Min. (Vailey) VOHV During Switching of Other Outputs (Output Under Test Not Switching)	VOHV See Figure 1	5	0.5 Typical at +25°C					V
Max. (Peak) VOLP During Switching of Other Outputs (Output Under Test Not Switching)	VOLP See Figure 1	5	1 Typical at +25°C					V
Input Capacitance	CI	•	•	-	10	•	10	pF
Input/Output Capacitance	CI/O	•	•	-	15	•	15	pF

† 5V: min. is at 5.5V, max. is at 4.5V.

5V: min. is at 5.25V for 0°C to +70°C, max. is at 4.75V for 0°C to +70°C, typ. is at 5V

§ CPD, measured per function, is used to determine the dynamic power consumption. PD (per package) = VCC ICC + Σ (VCC² fi CPD + VO² fo CL + VCC Δ ICC D) where:

VCC = supply voltage ΔICC = flow through current x unit load

CL = output load capacitance

D = duty cycle of input high

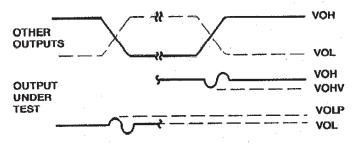
fo = output frequency

fl = input frequency

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PARAMETER MEASUREMENT INFORMATION



NOTES:

- 1. VOLP is measured with respect to a ground reference near the output under test. VOHV is measured with respect to VOH.
- 2. Input pulses have the following characteristics: $\rm PRR \leq 1 MHz, \, tr$ = 2.5ns, tf = 2.5ns, skew 1ns.
- R.F. fixture with 700-MHz design rules required. IC should be soldered into test board and bypassed with 0.1μF capacitor. Scope and probes require 700-MHz bandwidth.

Figure 1 - Simultaneous switching transient waveforms.

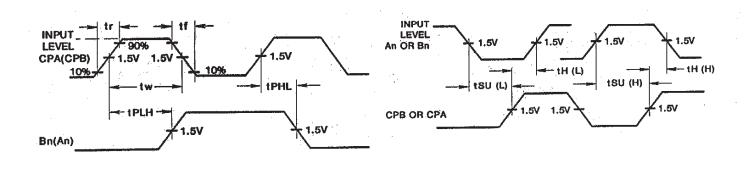
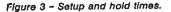
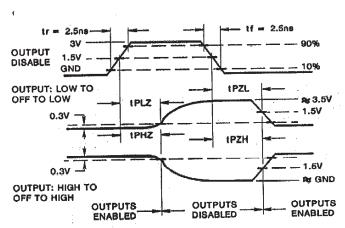
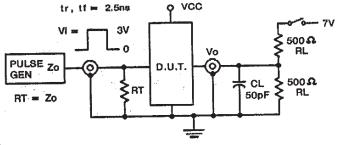


Figure 2 - CD54/74FCT2952A propagation delay times.







TEST	SWITCH POSITION				
tPLZ, tPZL, OPEN DRAIN	CLOSED				
tPHZ, tPZH, tPLH, tPHL	OPEN				

Figure 4 - Three-state propagation delay times and test circuit.

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